

Application/Control No.	Applicant(s)/Patent under Reexamination
10/511,632	IKEDA ET AL.
Examiner	Art Unit
Bethany P. Barham	1615

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East (See attached search notes)	11/21/2007	BB		
STIC structure search	11/21/2007	ВВ		
Palm Inventors Search	11/21/2007	ВВ		
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